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18dB High Gain Low Noise Amplifier for LTE Highband

Features

• Operating frequencies: 2300 - 2690 MHz

Insertion power gain: 18.1 dB

• Insertion Loss in bypass mode: 5.2 dB

Low noise figure: 0.7 dB

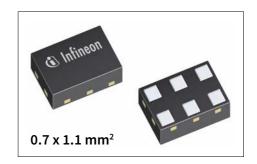
Low current consumption: 8.5 mA

Multi-state control: Bypass- and high gain-Mode

Ultra small TSNP-6-10 leadless package

· RF output internally matched to 50 Ohm

· Low external component count



Application

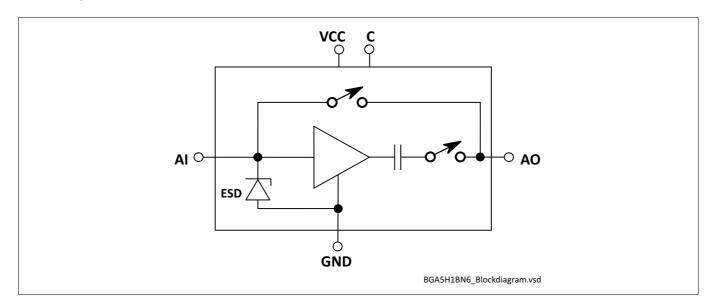
The LTE data rate can be significantly improved by using the Low Noise Amplifier. The integrated bypass function increases the overall system dynamic range and leads to more flexibility in the RF front-end.

In high gain mode the LNA offers best Noise Figure to ensure high data rates even on the LTE cell edge. Closer to the basestation the bypass mode can be activated reducing current consumption.

Product Validation

Qualified for industrial applications according to the relevant tests of JEDEC47/20/22

Block diagram



Data Sheet www.infineon.com

18dB High Gain Low Noise Amplifier for LTE Highband



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2

18dB High Gain Low Noise Amplifier for LTE Highband



Features

1 Features

• Insertion power gain: 18.1 dB

• Insertion Loss in bypass mode: 5.2 dB

Low noise figure: 0.7 dB

· Low current consumption: 8.5 mA

• Operating frequencies: 2300 - 2690 MHz

Multi-state control: Bypass- and High gain-Mode

Supply voltage: 1.5 V to 3.6 V

Ultra small TSNP-6-10 leadless package (footprint: 0.7 x 1.1 mm²)

• B9HF Silicon Germanium technology

RF output internally matched to 50 Ohm

· Low external component count

• Pb-free (RoHS compliant) package





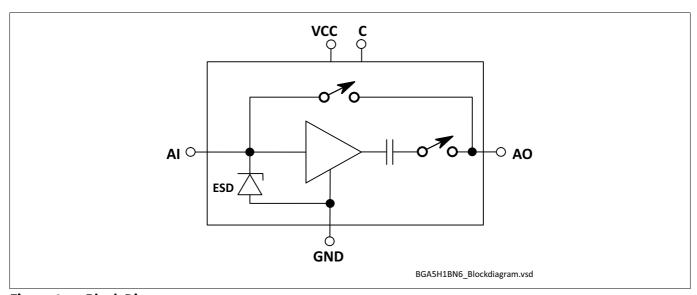


Figure 1 Block Diagram

Product Name	Marking	Package		
BGA5H1BN6	4	TSNP-6-10		

18dB High Gain Low Noise Amplifier for LTE Highband



Features

Description

The BGA5H1BN6 is a front-end low noise amplifier for LTE which covers a wide frequency range from 2300 MHz to 2690 MHz. The LNA provides 18.1 dB gain and 0.7 dB noise figure at a current consumption of 8.5 mA in the application configuration described in Chapter 4. In bypass mode the LNA provides an insertion loss of 5.2 dB. The BGA5H1BN6 is based upon Infineon Technologies' B9HF Silicon Germanium technology. It operates from 1.5 V to 3.6 V supply voltage. The device features a single-line two-state control (Bypass- and High gain-Mode). OFF-state can be enabled by powering down VCC.

Pin Definition and Function

Table 1 **Pin Definition and Function**

Pin No.	Name	Function
1	GND	Ground
2	VCC	DC supply
3	AO	LNA output
4	GND	Ground
5	Al	LNA input
6	С	Control

18dB High Gain Low Noise Amplifier for LTE Highband



Maximum Ratings

Maximum Ratings 2

Table 2 **Maximum Ratings**

Parameter	Symbol		Value	Unit	Note or		
		Min.	Тур.	Max.		Test Condition	
Voltage at pin VCC	$V_{\rm CC}$	-0.3	_	3.6	V	1)	
Voltage at pin Al	V_{AI}	-0.3	_	0.9	V	_	
Voltage at pin AO	V_{AO}	-0.3	-	V _{CC} + 0.3	V	_	
Voltage at pin C	V _C	-0.3	_	V _{CC} + 0.3	V	_	
Voltage at pin GND	$V_{\sf GND}$	-0.3	_	0.3	V	_	
Current into pin VCC	I _{CC}	_	_	16	mA	_	
RF input power	P _{IN}	_	_	+25	dBm	_	
Total power dissipation, $T_S < 148 ^{\circ}C^{2)}$	P _{tot}	-	-	60	mW	-	
Junction temperature	T_{J}	_	_	150	°C	_	
Ambient temperature range	T_{A}	-40	_	85	°C	-	
Storage temperature range	$T_{\rm STG}$	-55	-	150	°C	_	

¹⁾ All voltages refer to GND-Node unless otherwise noted

Attention: Stresses above the max. values listed here may cause permanent damage to the device. Maximum ratings are absolute ratings; exceeding only one of these values may cause irreversible damage to the integrated circuit. Exposure to conditions at or below absolute maximum rating but above the specified maximum operation conditions may affect device reliability and life time. Functionality of the device might not be given under these conditions.

²⁾ $T_{\rm S}$ is measured on the ground lead at the soldering point



Electrical Characteristics

Electrical Characteristics 3

Electrical Characteristics V_{CC} = 1.8V¹⁾

 $T_{\rm A}$ = 25 °C, $V_{\rm CC}$ = 1.8 V, $V_{\rm C,BP}$ = 1.8 V, $V_{\rm C,OFF}$ = 0 V, f = 2300 - 2690 MHz

Parameter	Symbol		Value	S	Unit	Note or Test Condition	
		Min.	Тур.	Max.			
Supply voltage	$V_{\rm CC}$	1.5	1.8	3.6	٧	-	
Control voltages	V_{C}	1.0	_	V_{CC}	٧	High gain mode	
		0	_	0.4	٧	Bypass mode	
Supply current	I _{CC}	-	8.5	10.3	mA	High gain mode	
		-	85	120	μΑ	Bypass mode	
Insertion power gain	$ S_{21} ^2$	16.4	18.1	19.8	dB	High gain mode	
f = 2500 MHz		-6.5	-5.2	-3.9	dB	Bypass mode	
Noise figure ²⁾	NF	-	0.7	1.2	dB	High gain mode	
$f = 2500 \text{ MHz}, Z_{S} = 50 \Omega$		-	5.2	6.5	dB	Bypass mode	
Input return loss ³⁾	RL _{IN}	7	10	_	dB	High gain mode	
f= 2500 MHz		5	8	_	dB	Bypass mode	
Output return loss³)	RL _{OUT}	10	20	_	dB	High gain mode	
f= 2500 MHz		3	5	_	dB	Bypass mode	
Reverse isolation ³⁾	$1/ S_{12} ^2$	25	36	_	dB	High gain mode	
f = 2500 MHz		3.9	5.2	_	dB	Bypass mode	
Power on time ⁴⁾⁶⁾	t_{S}	-	3	7	μs	OFF to High gain mode	
nband input 1dB-compression	IP _{1dB}	-21	-17	_	dBm	High gain mode	
point, <i>f</i> = 2500 MHz ³⁾		-7	-3	_	dBm	Bypass mode	
Inband input 3 rd -order	IIP ₃	-12	-7	_	dBm	High gain mode	
ntercept point ³⁾⁵⁾ $f_1 = 2500 \text{ MHz}, f_2 = f_1 + / - 1 \text{ MHz}$		1	6	-	dBm	Bypass mode	
Stability ⁶⁾	k	> 1	_	_		f = 20 MHz 10 GHz	

- 1) Based on the application described in **Chapter 4**
- 2) PCB losses are subtracted
- 3) Verification based on AQL; not 100% tested in production
- 4) Gain changed to >90% of gain difference (in dB)
- 5) Input power HG = -30 dBm for each tone; input power BP = -10 dBm for each tone
- 6) Guaranteed by device design; not tested in production

18dB High Gain Low Noise Amplifier for LTE Highband



Electrical Characteristics

Electrical Characteristics V_{cc} = 2.8V¹⁾

 $T_{\rm A}$ = 25 °C, $V_{\rm CC}$ = 2.8 V, $V_{\rm C,BP}$ = 2.8 V, $V_{\rm C,OFF}$ = 0 V, f = 2300 - 2690 MHz

Parameter	Symbol		Value	5	Unit	Note or Test Condition	
		Min.	Тур.	Max.			
Supply voltage	$V_{\rm cc}$	1.5	2.8	3.6	٧	-	
Control voltages	V _C	1.0	_	$V_{\rm CC}$	٧	High gain mode	
		0	_	0.4	٧	Bypass mode	
Supply current	I _{CC}	-	9.8	11.6	mA	High gain mode	
		_	87	120	μΑ	Bypass mode	
Insertion power gain	$ S_{21} ^2$	16.6	18.3	20.0	dB	High gain mode	
f = 2500 MHz		-6.5	-5.2	-3.9	dB	Bypass mode	
Noise figure ²⁾	NF	_	0.7	1.2	dB	High gain mode	
$f = 2500 \text{ MHz}, Z_{S} = 50 \Omega$		_	5.2	6.5	dB	Bypass mode	
Input return loss ³⁾	RL _{IN}	7	10	_	dB	High gain mode	
f = 2500 MHz		5	8	_	dB	Bypass mode	
Output return loss ³⁾	RL _{OUT}	10	19	_	dB	High gain mode	
f = 2500 MHz		3	5	_	dB	Bypass mode	
Reverse isolation ³⁾	$1/ S_{12} ^2$	25	36	_	dB	High gain mode	
f = 2500 MHz		3.9	5.2	_	dB	Bypass mode	
Power on time ⁴⁾⁶⁾	t_{S}	-	3	7	μs	OFF to High gain mode	
Inband input 1dB-compression	IP _{1dB}	-20	-16	_	dBm	High gain mode	
point, <i>f</i> = 2500 MHz ³⁾		-6	-2	_	dBm	Bypass mode	
Inband input 3 rd -order	IIP ₃	-11	-6	_	dBm	High gain mode	
intercept point ³⁾⁵⁾ $f_1 = 2500 \text{ MHz}, f_2 = f_1 + / -1 \text{ MHz}$		1	6	_	dBm	Bypass mode	
Stability ⁶⁾	k	> 1	-	-		f = 20 MHz 10 GHz	

- 1) Based on the application described in Chapter 4
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Application Information

Application Information 4

Application Board Configuration

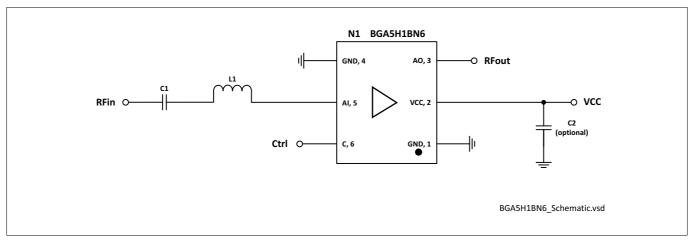


Figure 2 **Application Schematic BGA5H1BN6**

Bill of Materials Table 5

Name	Value	Package	Manufacturer	Function
C1	1nF	0402	Various	Input matching
C2 (optional)	≥ 1nF	0402	Various	RF bypass 1)
L1	3.6nH	0402	Murata LQW15 type	Input matching
N1	BGA5H1BN6	TSNP-6-10	Infineon	SiGe LNA

¹⁾ RF bypass recommended to mitigate power supply noise

A list of all application notes is available at http://www.infineon.com/ltelna



Package Information

5 Package Information

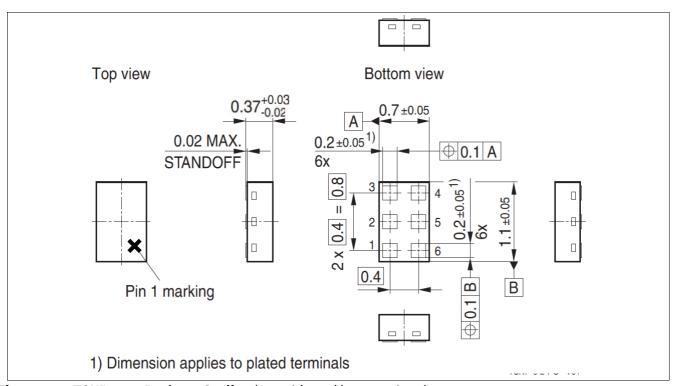


Figure 3 TSNP-6-10 Package Outline (top, side and bottom views)

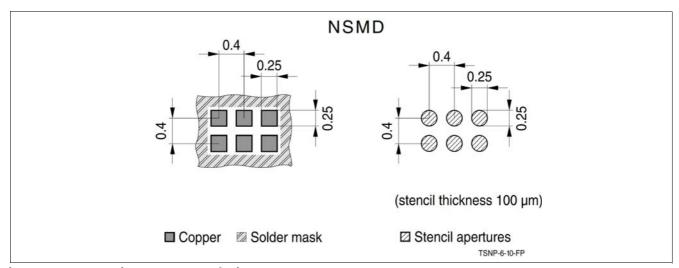


Figure 4 Footprint Recommendation TSNP-6-10



Package Information

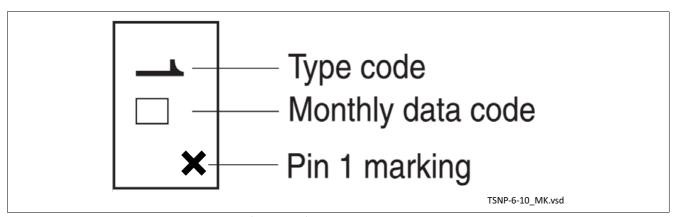


Figure 5 Marking Layout TSNP-6-10 (top view)

Mont	h 2	2015	2016	2017	2018	2019	2020	2021	2022	2023	2024	2025	2026
01		а	Р	А	Р	а	Р	А	Р	а	Р	Α	Р
02		Ь	q	В	Q	Ь	q	В	Q	Ь	q	В	Q
03		C	Γ	(R	С	Γ	C	R	C	Γ	C	R
04		d	S	D	S	d	s	D	S	В	S	D	S
05		e	†	Ε	Т	е	t	E	T	e	t	Е	Т
06		f	И	F	U	f	u	F	U	f	U	F	U
07		g	V	G	V	g	V	G	V	g	V	G	V
08		h	X	Н	X	h	×	Н	X	h	×	Н	X
09		j	у	J	Υ	j	у	J	Y	j	у	J	Υ
10		k	Z	K	Z	k	Z	K	Z	k	Z	K	Z
11		l	2	L	4	l	2	L	4	l	2	L	4
12		Π	3	Ν	5	n	3	Ν	5	n	3	Ν	5

Figure 6 Date Code Marking TSNP-6-10

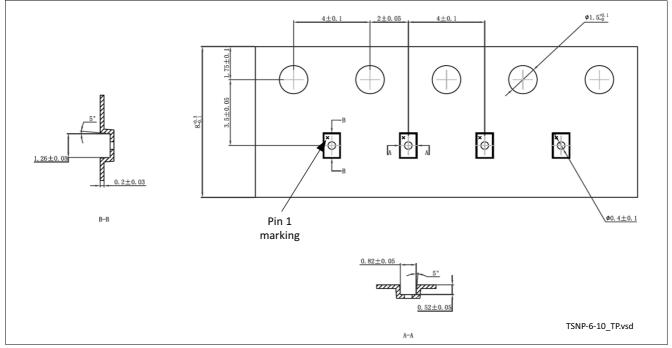


Figure 7 Tape & Reel Dimensions TSNP-6-10 (reel diameter 180 mm, pieces/reel 12000)

18dB High Gain Low Noise Amplifier for LTE Highband



Revision History										
Page or Item	Subjects (major changes since previous revision)									
Revision 2.2, 2	018-03-15									
5	Update Maximum Ratings									

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